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Application/Control No.	Applicant(s)/Patent under Reexamination
10/717,697	FUKUHISA ET AL.
Examiner	Art Unit
Sam Dillon	2185

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Keyword and Text update search (EAST)	9/15/2006	SAD		
Non Patent Literature Search	9/15/2006	SAD		
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